



54ACT/74ACT368 Hex Inverter Buffer with TRI-STATE® Outputs

General Description

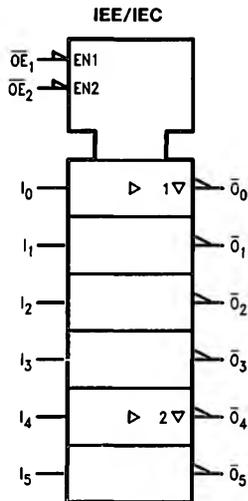
The 'ACT368 contains six independent inverting buffers with TRI-STATE outputs.

Features

- Outputs source/sink 24 mA
- 'ACT has TTL-compatible inputs

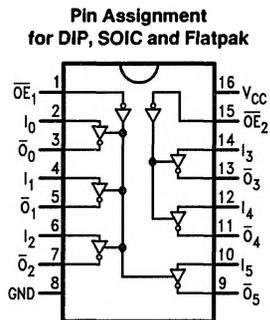
Ordering Code: See Section 8

Logic Symbols

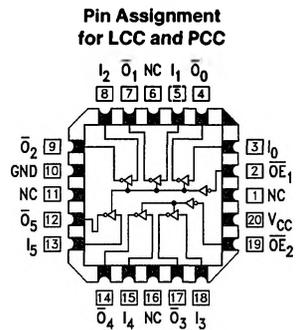


TL/F/10690-1

Connection Diagrams



TL/F/10690-2



TL/F/10690-3

Function Table

Inputs		Output
\overline{OE}	I	\overline{O}
L	L	H
L	H	L
H	X	Z

Pin Names	Description
$\overline{OE}_1, \overline{OE}_2$	Output Enable Input (Active LOW)
\overline{O}_n	Input Output

L = LOW Voltage Level
 H = HIGH Voltage Level
 X = Immaterial
 Z = High Impedance

Absolute Maximum Ratings (Note 1)

If Military/Aerospace specified devices are required, please contact the National Semiconductor Sales Office/Distributors for availability and specifications.

Supply Voltage (V_{CC})	-0.5V to +7.0V
DC Input Diode Current (I_{IK})	
$V_I = -0.5V$	-20 mA
$V_I = V_{CC} + 0.5V$	+20 mA
DC Input Voltage (V_I)	-0.5V to $V_{CC} + 0.5V$
DC Output Diode Current (I_{OK})	
$V_O = -0.5V$	-20 mA
$V_O = V_{CC} + 0.5V$	+20 mA
DC Output Voltage (V_O)	-0.5V to $V_{CC} + 0.5V$
DC Output Source or Sink Current (I_O)	± 50 mA
DC V_{CC} or Ground Current per Output Pin (I_{CC} or I_{GND})	± 50 mA
Storage Temperature (T_{STG})	-65°C to +150°C
Junction Temperature (T_J)	
CDIP	175°C
PDIP	140°C

Note 1: Absolute maximum ratings are those values beyond which damage to the device may occur. The databook specifications should be met, without exception, to ensure that the system design is reliable over its power supply, temperature, and output/input loading variables. National does not recommend operation of FACT™ circuits outside databook specifications.

Recommended Operating Conditions

Supply Voltage (V_{CC})	
'AC	2.0V to 6.0V
'ACT	4.5V to 5.5V
Input Voltage (V_I)	0V to V_{CC}
Output Voltage (V_O)	0V to V_{CC}
Operating Temperature (T_A)	
74AC/ACT	-40°C to +85°C
54AC/ACT	-55°C to +125°C
Minimum Input Edge Rate ($\Delta V/\Delta t$)	
'AC Devices	
V_{IN} from 30% to 70% of V_{CC}	
V_{CC} @3.3V, 4.5V, 5.5V	125 mV/ns
Minimum Input Edge Rate ($\Delta V/\Delta t$)	
'ACT Devices	
V_{IN} from 0.8V to 2.0V	
V_{CC} @4.5V, 5.5V	125 mV/ns

DC Electrical Characteristics for 'ACT Family Devices

Symbol	Parameter	V_{CC} (V)	74ACT			54ACT	74ACT	Units	Conditions
			$T_A = +25^\circ\text{C}$			$T_A = -55^\circ\text{C to } +125^\circ\text{C}$	$T_A = -40^\circ\text{C to } +85^\circ\text{C}$		
			Typ	Guaranteed Limits					
V_{IH}	Minimum High Level Input Voltage	4.5	1.5	2.0	2.0	2.0	V	$V_{OUT} = 0.1V$ or $V_{CC} - 0.1V$	
		5.5	1.5	2.0	2.0	2.0			
V_{IL}	Maximum Low Level Input Voltage	4.5	1.5	0.8	0.8	0.8	V	$V_{OUT} = 0.1V$ or $V_{CC} - 0.1V$	
		5.5	1.5	0.8	0.8	0.8			
V_{OH}	Minimum High Level Output Voltage	4.5	4.49	4.4	4.4	4.4	V	$I_{OUT} = -50 \mu\text{A}$	
		5.5	5.49	5.4	5.4	5.4			
		4.5		3.86	3.70	3.76	V	* $V_{IN} = V_{IL}$ or V_{IH} -24 mA I_{OH} -24 mA	
		5.5		4.86	4.70	4.76			
V_{OL}	Maximum Low Level Output Voltage	4.5	0.001	0.1	0.1	0.1	V	$I_{OUT} = 50 \mu\text{A}$	
		5.5	0.001	0.1	0.1	0.1			
		4.5		0.36	0.50	0.44	V	* $V_{IN} = V_{IL}$ or V_{IH} 24 mA I_{OL} 24 mA	
		5.5		0.36	0.50	0.44			
I_{IN}	Maximum Input Leakage Current	5.5		± 0.1	± 1.0	± 1.0	μA	$V_I = V_{CC}, GND$	
I_{OZ}	Maximum TRI-STATE Current	5.5		± 0.5	± 10.0	± 5.0	μA	$V_I = V_{IL}, V_{IH}$ $V_O = V_{CC}, GND$	

*All outputs loaded; thresholds on input associated with output under test.

†Maximum test duration 2.0 ms, one output loaded at a time.

DC Electrical Characteristics for 'ACT Family Devices (Continued)

Symbol	Parameter	V _{CC} (V)	74ACT		54ACT		74ACT		Units	Conditions
			T _A = +25°C		T _A = -55°C to +125°C		T _A = -40°C to +85°C			
			Typ	Guaranteed Limits						
I _{CC} T	Maximum I _{CC} /Input	5.5	0.6		1.6		1.5		mA	V _I = V _{CC} - 2.1V ††
I _{OLD}	†Minimum Dynamic Output Current	5.5			50		75		mA	V _{OLD} = 1.65V Max
I _{OHD}		5.5			-50		-75		mA	V _{OHD} = 3.85V Min
I _{CC}	Maximum Quiescent Supply Current	5.5		8.0	160.0		80.0		μA	V _{IN} = V _{CC} or GND

*All outputs loaded; thresholds on input associated with output under test.

†Maximum test duration 2.0 ms, one output loaded at a time.

††May be measured per the JEDEC Alternate Method.

Note: I_{CC} for 54ACT @ 25°C is identical to 74ACT @ 25°C.

AC Electrical Characteristics: See Section 2 for Waveforms

Symbol	Parameter	V _{CC} * (V)	74ACT			54ACT		74ACT		Units	Fig. No.
			T _A = +25°C C _L = 50 pF			T _A = -55°C to +125°C C _L = 50 pF		T _A = -40°C to +85°C C _L = 50 pF			
			Min	Typ	Max	Min	Max	Min	Max		
t _{PLH}	Propagation Delay	5.0	1.0	6.5	9.0			1.0	10.0	ns	2-3, 4
t _{PHL}	Propagation Delay	5.0	1.0	6.0	9.0			1.0	10.0	ns	2-3, 4
t _{PZH}	Output Enable Time	5.0	1.0	8.0	10.0			1.0	11.0	ns	2-5
t _{PZL}	Output Enable Time	5.0	1.0	8.0	12.0			1.0	13.0	ns	2-6
t _{PHZ}	Output Disable Time	5.0	1.0	9.0	12.0			1.0	13.0	ns	2-5
t _{PLZ}	Output Disable Time	5.0	1.0	8.5	11.0			1.0	12.0	ns	2-6

*Voltage Range 5.0 is 5.0V ±0.5V.

Capacitance

Symbol	Parameter	AC/ACT		Units	Conditions
		Typ			
C _{IN}	Input Capacitance	4.5		pF	V _{CC} = 5.0V
C _{PD}	Power Dissipation Capacitance	40.0		pF	V _{CC} = 5.0V